# UNISONIC TECHNOLOGIES CO., LTD

UT40N03 **Power MOSFET** 

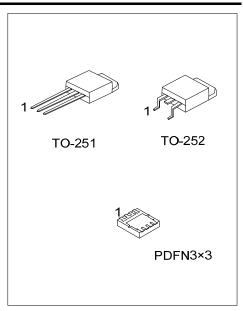
## 40 Amps, 30 Volts **N-CHANNEL POWER MOSFET**

#### DESCRIPTION

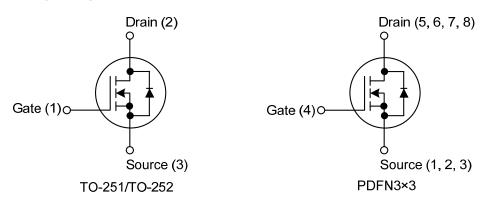
The UT40N03 power MOSFET provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness

#### **FEATURES**

- \*  $R_{DS(ON)} \le 17 \text{ m}\Omega @ V_{GS} = 10V, I_D = 20A$
- \* Low capacitance
- \* Optimized gate charge
- \* Fast switching capability
- \* Avalanche energy specified



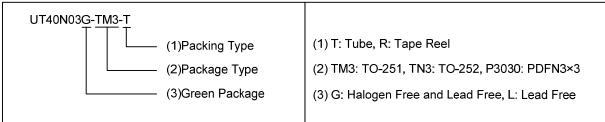
### **SYMBOL**



#### ORDERING INFORMATION

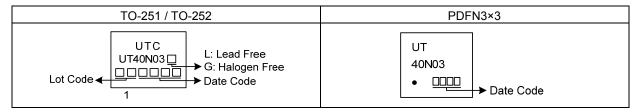
Ordering Number		Daakasa	Pin Assignment							Doolsing	
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing
UT40N03L-TM3-T UT40N03G-TM3-T		TO-251	G	D	S	-	-	-	-	-	Tube
UT40N03L-TN3-R	UT40N03G-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
UT40N03L-P3030-R	UT40N03G-P3030-R	PDFN3×3	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



UT40N03 Power MOSFET

## MARKING



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## ■ **ABSOLUTE MAXIMUM RATINGS** (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	30	V
Gate-Source Voltage		$V_{GSS}$	±20	V
Continuous Drain Current		$I_{D}$	40	Α
Pulsed Drain Current (Note 1)		$I_{DM}$	80	Α
Total Dawar Dissination	TO-251/TO-252	$P_D$	48	W
otal Power Dissipation	PDFN3×3		20	W
Junction Temperature		$T_J$	+150	°C
Storage Temperature		$T_{STG}$	-55 ~ <b>+</b> 150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

### ■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
lungtion to Ambient	TO-251/TO-252	0	50	°C/W
Junction to Ambient	PDFN3×3	$\theta_{JA}$	65	°C/W
lunation to Casa	TO-251/TO-252	$\theta_{JC}$	2.6	°C/W
Junction to Case	PDFN3×3		6.25	°C/W

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

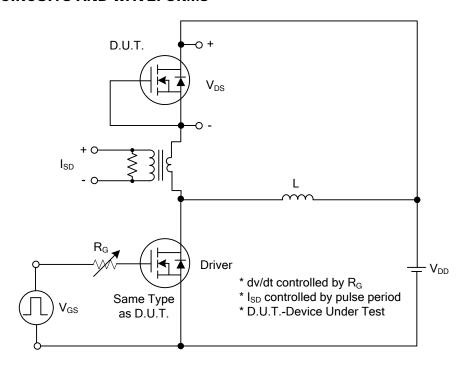
## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> =25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS			_		_		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0 V, I <sub>D</sub> =250 μA	30			V	
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =30 V, V <sub>GS</sub> =0 V, T <sub>J</sub> =25℃			1	μΑ	
Gate- Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V			±100	nA	
ON CHARACTERISTICS							
Gate-Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1		3	V	
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS}$ =10 V, $I_{D}$ =20 A		14	17	mΩ	
Drain-Source On-State Resistance		V <sub>GS</sub> =4.5 V, I <sub>D</sub> =16 A		20	23		
DYNAMIC PARAMETERS					-	-	
Input Capacitance	C <sub>ISS</sub>			600			
Output Capacitance	Coss	V <sub>DS</sub> =25 V, V <sub>GS</sub> =0V, f=1.0MHz		145		pF	
Reverse Transfer Capacitance	C <sub>RSS</sub>			125			
SWITCHING PARAMETERS							
Total Gate Charge	$Q_{G}$			24			
Gate-Source Charge	$Q_{GS}$	V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A		3		nC	
Gate-Drain Charge	$Q_{GD}$			6			
Turn-ON Delay Time	t <sub>D(ON)</sub>			14			
Turn-ON Rise Time	t <sub>R</sub>	$V_{DS}$ =15 V, $V_{GS}$ =10V, $I_{D}$ =1.0A,		18		ns	
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	$R_G = 3.3 \Omega, R_L = 0.75 \Omega$		32			
Turn-OFF Fall-Time	t <sub>F</sub>			28			
SOURCE- DRAIN DIODE RATINGS AN	D CHARACT	ERISTICS					
Maximum Continuous Drain-Source					40		
Diode Forward Current	I <sub>S</sub>						
Maximum Pulsed Drain-Source Diode	I <sub>SM</sub>				80	Α	
Forward Current					00		
Drain-Source Diode Forward Voltage	$V_{SD}$	$T_J=25^{\circ}C$ , $I_S=40A$ , $V_{GS}=0V$			1.3	V	

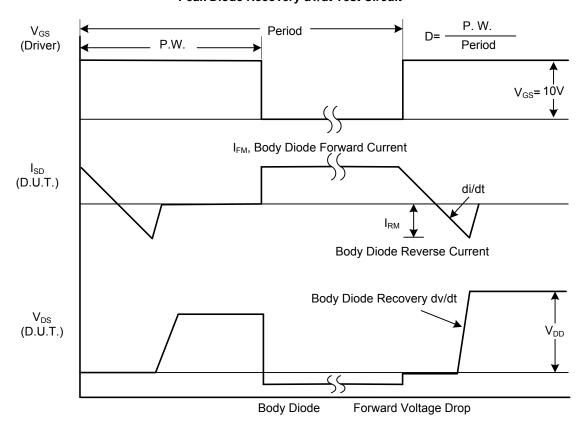
Notes: 1. Repetitive rating; pulse width limited by max. junction temperature.

2. Pulse width  $\leq$  300us, duty cycle  $\leq$  2%.

### **■ TEST CIRCUITS AND WAVEFORMS**



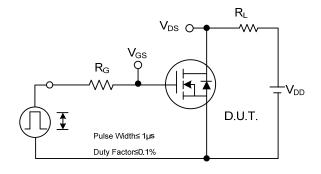
## Peak Diode Recovery dv/dt Test Circuit

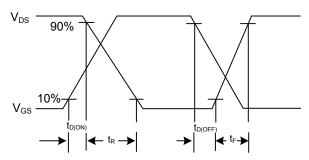


Peak Diode Recovery dv/dt Waveforms

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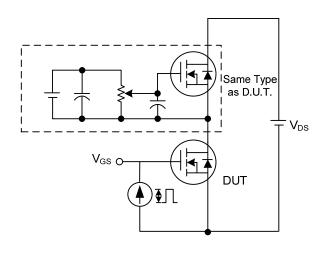
## ■ TEST CIRCUITS AND WAVEFORMS

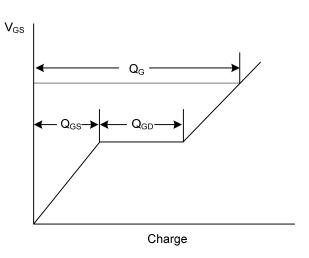




**Switching Test Circuit** 

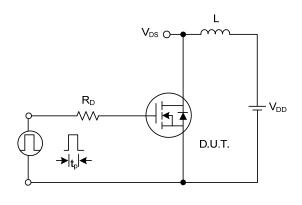
**Switching Waveforms** 

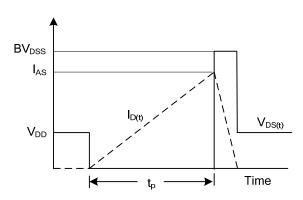




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

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